

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/604,546 | Applicant(s)/Patent Under Reexamination SUN ET AL. | |
| | Examiner TAN X. DINH | Art Unit 2627 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-5,623,461 A | 04-1997 | Sohmuta, Mitoshi | 369/30.17 |
| * | B | US-5,428,590 A | 06-1995 | Ogino, Tsukasa | 369/30.17 |
| * | C | US-7,193,935 B2 | 03-2007 | Hong et al. | 369/30.27 |
| * | D | US-6,414,915 B2 | 07-2002 | Seo, Jee-Won | 369/30.1 |
| * | E | US-6,172,949 B1 | 01-2001 | Ogata, Hitoshi | 369/30.1 |
| * | F | US-5,808,982 A | 09-1998 | Yun, Ki-bong | 369/30.15 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.